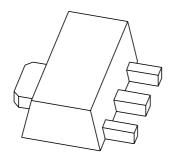
DISCRETE SEMICONDUCTORS

DATA SHEET



PBSS4480X 80 V, 4 A NPN low V_{CEsat} (BISS) transistor

Product data sheet Supersedes data of 2004 Aug 5

2004 Oct 25



80 V, 4 A NPN low V_{CEsat} (BISS) transistor

PBSS4480X

FEATURES

- High h_{FE} and low V_{CEsat} at high current operation
- High collector current capability: IC maximum 4 A
- · High efficiency leading to less heat generation.

APPLICATIONS

- Medium power peripheral drivers; e.g. fan, motor
- Strobe flash units for DSC and mobile phones
- Inverter applications; e.g. TFT displays
- · Power switch for LAN and ADSL systems
- Medium power DC-to-DC conversion
- · Battery chargers.

DESCRIPTION

NPN low V_{CEsat} transistor in a SOT89 (SC-62) plastic package.

PNP complement: PBSS5480X.

MARKING

TYPE NUMBER	MARKING CODE ⁽¹⁾
PBSS4480X	*1Y

Note

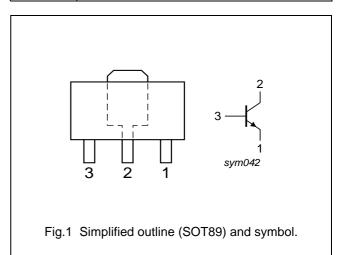
- 1. * = p: made in Hong Kong.
 - * = t: made in Malaysia.
 - * = W: made in China.

QUICK REFERENCE DATA

SYMBOL	PARAMETER	MAX.	UNIT
V _{CEO}	collector-emitter voltage	80	V
I _C	collector current (DC)	4	Α
I _{CM}	peak collector current	10	Α
R _{CEsat}	equivalent on-resistance	54	mΩ

PINNING

PIN	DESCRIPTION
1	emitter
2	collector
3	base



ORDERING INFORMATION

TYPE NUMBER	PACKAGE			
TIFE NOWIBER	NAME DESCRIPTION VERSION			
PBSS4480X	 plastic surface mounted package; collector pad for good heat transfer; 3 leads 		SOT89	

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LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 60134).

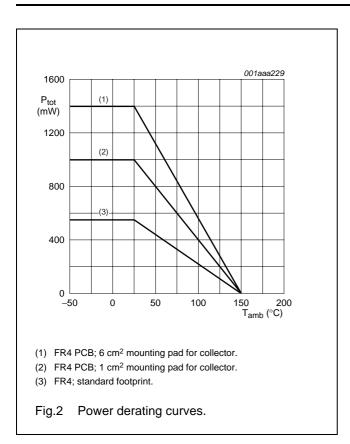
SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
V _{CBO}	collector-base voltage	open emitter	_	80	V
V _{CEO}	collector-emitter voltage	open base	_	80	V
V _{EBO}	emitter-base voltage	open collector	_	5	V
I _C	collector current (DC)	note 4	_	4	Α
I _{CRM}	repetitive peak collector current	$t_p \le 10 \text{ ms}; \ \delta \le 0.1$	_	6	Α
I _{CM}	peak collector current	$t = 1 \text{ ms or limited by } T_{j(max)}$	_	10	Α
I _B	base current (DC)		_	1	Α
I _{BM}	peak base current	t ≤ 300 μs	_	2	А
P _{tot}	total power dissipation	T _{amb} ≤ 25 °C			
		notes 1 and 2	_	2.5	W
		note 2	_	550	mW
		note 3	_	1	W
		note 4	_	1.4	W
		note 5	_	1.6	W
Tj	junction temperature		_	150	°C
T _{amb}	ambient temperature		-65	+150	°C
T _{stg}	storage temperature		-65	+150	°C

Notes

- 1. Operated under pulsed conditions; pulse width $t_p \le 10$ ms; duty cycle $\delta \le 0.2$.
- 2. Device mounted on a printed-circuit board, single-sided copper, tin-plated and standard footprint.
- 3. Device mounted on a printed-circuit board, single-sided copper, tin-plated and mounting pad for collector 1 cm².
- 4. Device mounted on a printed-circuit board, single-sided copper, tin-plated and mounting pad for collector 6 cm².
- 5. Device mounted on a 7 cm² ceramic printed-circuit board, 1 cm² single-sided copper and tin-plated. For other mounting conditions, see *"Thermal considerations for SOT89 in the General Part of associated Handbook"*.

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THERMAL CHARACTERISTICS

SYMBOL	PARAMETER	CONDITIONS	VALUE	UNIT
R _{th(j-a)}	thermal resistance from junction	in free air		
	to ambient	notes 1 and 2	50	K/W
		note 2	225	K/W
		note 3	125	K/W
		note 4	90	K/W
		note 5	80	K/W
R _{th(j-s)}	thermal resistance from junction to soldering point		16	K/W

Notes

- 1. Operated under pulsed conditions; pulse width $t_p \le 10$ ms; duty cycle $\delta \le 0.2$.
- 2. Device mounted on a printed-circuit board, single-sided copper, tin-plated and standard footprint.
- 3. Device mounted on a printed-circuit board, single-sided copper, tin-plated and mounting pad for collector 1 cm².
- 4. Device mounted on a printed-circuit board, single-sided copper, tin-plated and mounting pad for collector 6 cm².
- 5. Device mounted on a 7 cm² ceramic printed-circuit board, 1 cm² single-sided copper and tin-plated. For other mounting conditions, see "Thermal considerations for SOT89 in the General Part of associated Handbook".

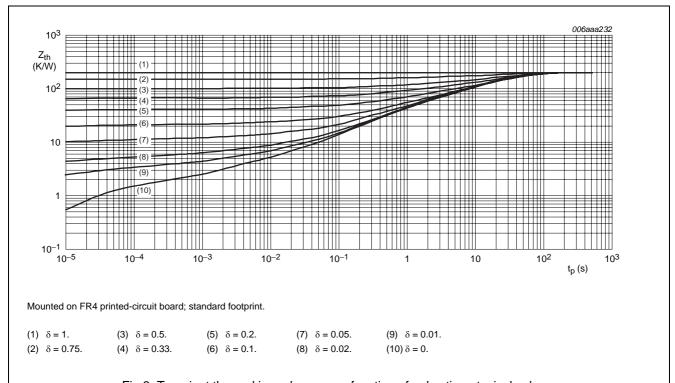
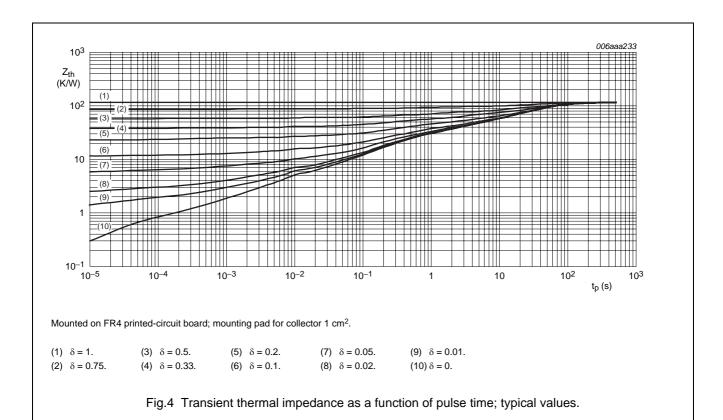


Fig.3 Transient thermal impedance as a function of pulse time; typical values.

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006aaa234 10³ Z_{th} (K/W) 10² 10 (7) (8) (9) _(10¹ 10^{-1} 10-5 10-3 10³ 10 t_p (s) Mounted on FR4 printed-circuit board; mounting pad for collector 6 cm². (1) $\delta = 1$. (3) $\delta = 0.5$. (7) $\delta = 0.05$. (9) $\delta = 0.01$. (5) $\delta = 0.2$. (2) $\delta = 0.75$. (4) $\delta = 0.33$. (6) $\delta = 0.1$. (8) $\delta = 0.02$. (10) $\delta = 0$. Fig.5 Transient thermal impedance as a function of pulse time; typical values.

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CHARACTERISTICS

 T_{amb} = 25 °C unless otherwise specified.

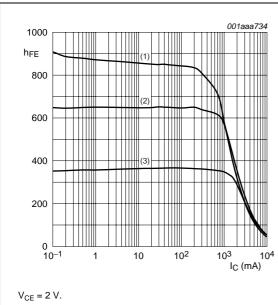
SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
I _{CBO}	collector-base cut-off current	$V_{CB} = 80 \text{ V}; I_{E} = 0 \text{ A}$	_	_	100	nA
		V _{CB} = 80 V; I _E = 0 A; T _j = 150 °C	_	_	50	μА
I _{CES}	collector-emitter cut-off current	V _{CE} = 80 V; V _{BE} = 0 V	_	_	100	nA
I _{EBO}	emitter-base cut-off current	$V_{EB} = 5 \text{ V}; I_{C} = 0 \text{ A}$	_	_	100	nA
h _{FE}	DC current gain	$V_{CE} = 2 \text{ V}; I_{C} = 0.5 \text{ A}$	250	400	_	_
		$V_{CE} = 2 \text{ V}; I_{C} = 1 \text{ A}; \text{ note } 1$	250	400	-	-
		$V_{CE} = 2 \text{ V}; I_{C} = 2 \text{ A}; \text{ note 1}$	175	270	_	_
		$V_{CE} = 2 \text{ V}; I_{C} = 4 \text{ A}; \text{ note 1}$	80	140	_	_
V _{CEsat}	collector-emitter saturation	$I_C = 0.5 \text{ A}; I_B = 50 \text{ mA}$	-	25	40	mV
	voltage	I _C = 1 A; I _B = 50 mA	_	55	80	mV
		$I_C = 2 \text{ A}; I_B = 40 \text{ mA}$	-	110	160	mV
		I _C = 4 A; I _B = 200 mA; note 1	_	170	230	mV
		I _C = 5 A; I _B = 500 mA; note 1	_	200	270	mV
R _{CEsat}	equivalent on-resistance	I _C = 5 A; I _B = 500 mA; note 1	_	40	54	mΩ
V _{BEsat}	base-emitter saturation voltage	$I_C = 0.5 \text{ A}; I_B = 50 \text{ mA}$	_	0.78	0.85	V
		I _C = 1 A; I _B = 50 mA	_	0.79	0.9	V
		I _C = 1 A; I _B = 100 mA; note 1	_	0.82	0.95	V
		I _C = 4 A; I _B = 400 mA; note 1	_	0.95	1.05	V
V _{BEon}	base-emitter turn-on voltage	I _C = 2 A; V _{CE} = 2 V	_	0.78	0.85	V
f _T	transition frequency	I _C = 100 mA; V _{CE} = 10 V; f = 100 MHz	120	150	_	MHz
C _c	collector capacitance	$I_E = i_e = 0 \text{ A}; V_{CB} = 10 \text{ V};$ f = 1 MHz	_	35	50	pF

Note

1. Pulse test: $t_p \le 300~\mu s;~\delta \le 0.02.$

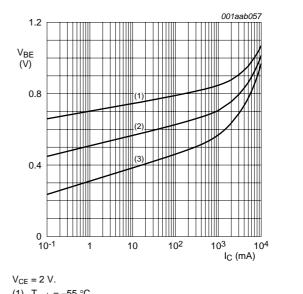
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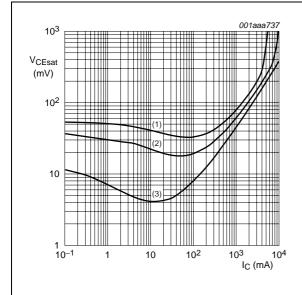
- (1) $T_{amb} = 100 \, ^{\circ}C$.
- (2) $T_{amb} = 25 \, ^{\circ}C$.
- (3) $T_{amb} = -55 \, ^{\circ}C$.

Fig.6 DC current gain as a function of collector current; typical values.



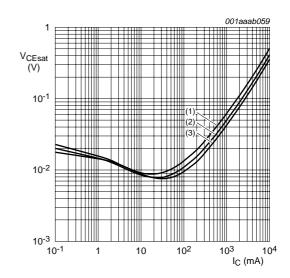
- (1) $T_{amb} = -55 \, ^{\circ}C$.
- (2) $T_{amb} = 25 \, ^{\circ}C$.
- (3) $T_{amb} = 100 \, ^{\circ}C$.

Base-emitter voltage as a function of collector current; typical values.



- (1) $I_C/I_B = 100$.
- (2) $I_C/I_B = 50$.
- (3) $I_C/I_B = 10$.

Collector-emitter saturation voltage as a function of collector current; typical values.



 $I_{\rm C}/I_{\rm B} = 20.$

- (1) $T_{amb} = 100 \, ^{\circ}C$.
- (2) $T_{amb} = 25 \, ^{\circ}C$.
- (3) $T_{amb} = -55 \, ^{\circ}C$.

Collector-emitter saturation voltage as a function of collector current; typical values.

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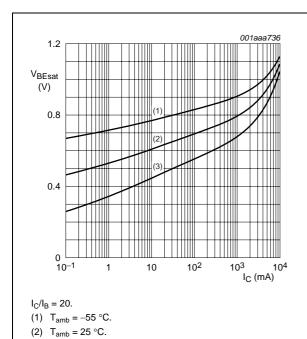


Fig.10 Base-emitter saturation voltage as a function of collector current; typical values.

(3) $T_{amb} = 100 \, ^{\circ}C$.

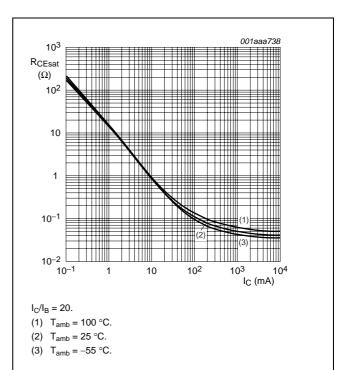
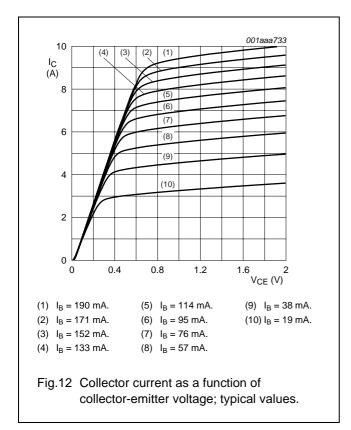
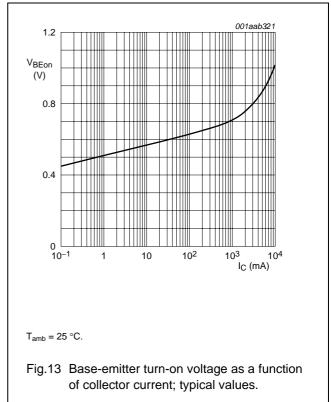


Fig.11 Equivalent on-resistance as a function of collector current; typical values.

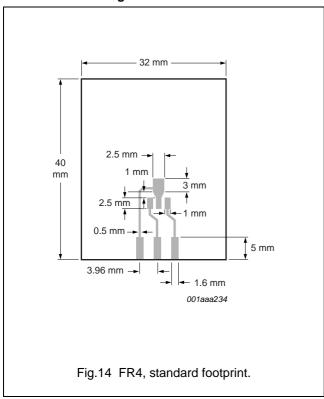


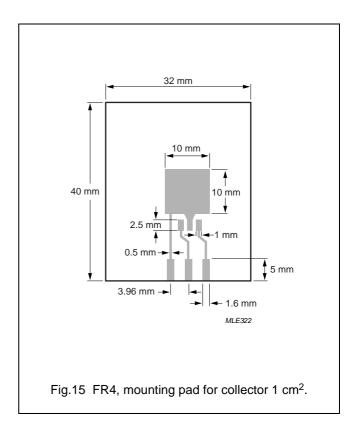


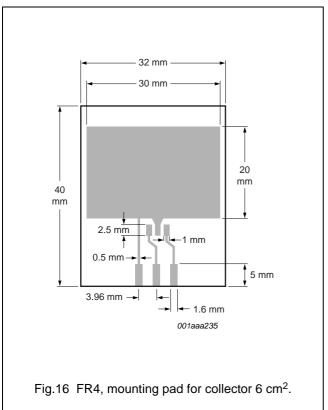
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Reference mounting conditions







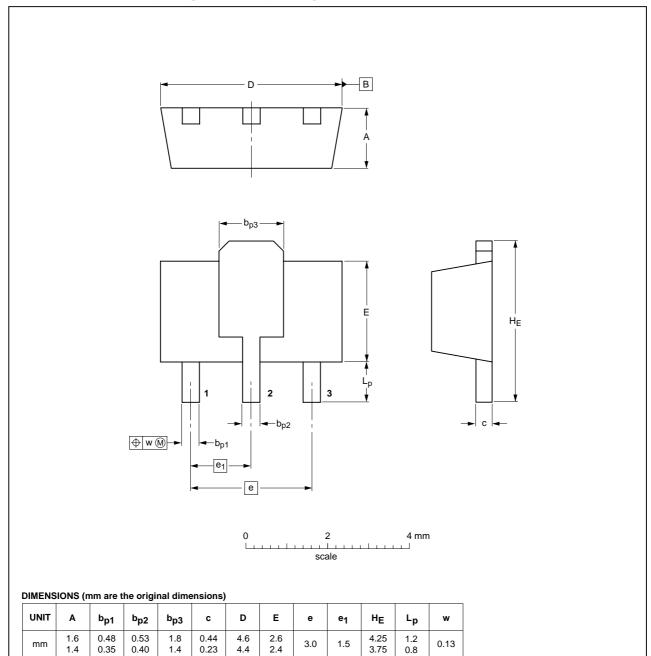
80 V, 4 A NPN low V_{CEsat} (BISS) transistor

PBSS4480X

PACKAGE OUTLINE

Plastic surface-mounted package; collector pad for good heat transfer; 3 leads

SOT89



OUTLINE	REFERENCES			EUROPEAN	ISSUE DATE	
VERSION	IEC	JEDEC	JEITA		PROJECTION ISSUE DAT	
SOT89		TO-243	SC-62			04-08-03 06-03-16

80 V, 4 A NPN low V_{CEsat} (BISS) transistor

PBSS4480X

DATA SHEET STATUS

DOCUMENT STATUS ⁽¹⁾	PRODUCT STATUS ⁽²⁾	DEFINITION
Objective data sheet	Development	This document contains data from the objective specification for product development.
Preliminary data sheet	Qualification	This document contains data from the preliminary specification.
Product data sheet	Production	This document contains the product specification.

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2004 Oct 25

NXP Semiconductors

Customer notification

This data sheet was changed to reflect the new company name NXP Semiconductors, including new legal definitions and disclaimers. No changes were made to the technical content, except for package outline drawings which were updated to the latest version.

Contact information

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